PCN Number: 202		220615004.1			PC	PCN Date:		June 16, 2022			
Title: Qualification of CF		of CFA	AB as an additional Fab site option			otions	ons for select		LBC3S devices		
Customer Contact:			PCN Manager				pt:		Quality Services		
Proposed 1 st Ship Date:			Sep 16, 2022			nple i ccept	ed u	ntil:	July 16, 2022*		
*Sample requests received after July 16, 2022 will not be supported.											
Change Typ				0				A	and the Mathematical		
Assembl	y Site		<u> </u>	Assembly F					ssembly Materials echanical Specification		
Test Site	<u>د</u>		Electrical Specification Packing/Shipping/Labeling			na	\square		t Process		
	ump Site		Wafer Bump Material			ing	\square		fer Bump Process		
Wafer Fa			Wafer Fab Materials					Wafer Fab Process			
			Part number change								
				PCN	Details						
Description											
					•				ation facilities as	an	
additional Wa	ifer Fab opti	on for	the	devices liste	ed in the "Proo	duct A	ffect	ed" se	ection.		
	Current F	ah Cil	-				low	Eah (lite		
	1	-				New Fab S					
Fab Site	Process	Wa		Diameter	Fab Site		oces		Wafer Diamete	er -	
DL-LIN	LBC3S		15	0 mm	CFAB	L	BC3S	5	200 mm		
	Qual details are provided in the Qual Data Section. Reason for Change:										
These changes are part of our multiyear plan to transition products from our 150-milimeter factories to newer, more efficient manufacturing processes and technologies, underscoring our commitment to product longevity and supply continuity.											
	Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):										
None											
Changes to	product ide	entific	atio	on resulting	from this P	CN:					
Fab Site In	formation:	1							T	1	
Chip Site		(Site Origin de (20L)	Chip Site	Chip Site Country C (21L)			Chip Site City	'	
DL-LIN				DLN		USA			Dallas		
CFAB				CU3		CHN		Chengdu			
Sample product shipping label (not actual product label):											
		ONGE		05000	TUCCOT			TIN (2	475.004/00		
MAX3238CD				8EDBR		LV2462IP			TLV2475CPWPR		
MAX3238ECDBR TLC0		TLC08	84AIN TLV2475AIPW			WP		TLV2	475IPWPR		

Texas Instruments Incorporated

TI Information - Selective Disclosure

PCN# 20220615004.1

MAX3238EIDBR	TLC085AIN	TLV2475AIPWPR	TRSF3238EIDBR	
MAX3238IDBR	TLV2462CP			

Qualification Report

Approve Date 13-Sept-2021

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Test Name / Condition	Duration	Qual Device: TLV2464CPWR	QBS Process Reference: CD3301RHHR	QBS Package Reference: TP S2042BD	QBS Package Reference: TP \$2419DR
Life Test, 150C	300 Hours	-	3/231/0	-	-
High Temp Storage Bake 170C	420 Hours	-	3/231/0	3/231/0	3/231/0
Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	-	3/231/0
Autoclave 121C	96 Hours	-	3/231/0	3/231/0	3/231/0
Temperature Cycle, -65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0
ESD - HBM	4000 V	1/3/0	1/3/0	-	-
ESD - CDM	1000 V	1/3/0	1/3/0	-	-
Latch-up	(per JESD78)	1/6/0	1/6/0	-	-
Electrical Characterization	Per Datasheet Parameters	1/30/0	1/30/0	-	-
Assembly MQ	Per Site Specifications	Pass	Pass	Pass	Pass
	Life Test, 150C High Temp Storage Bake 170C Biased HAST, 130C/85%RH Autoclave 121C Temperature Cycle, -65/150C ESD - HBM ESD - CDM Latch-up Electrical Characterization	Life Test, 150C 300 Hours High Temp Storage Bake 170C 420 Hours Biased HAST, 130C/85%RH 96 Hours Autoclave 121C 96 Hours Temperature Cycle, -65/150C 500 Cycles ESD - HBM 4000 V ESD - CDM 1000 V Latch-up (per JESD78) Electrical Characterization Per Datasheet Parameters Assembly MQ Per Site Specifications	Test Name / Condition Duration TLV2464CPWR Life Test, 150C 300 Hours - High Temp Storage Bake 170C 420 Hours - Biased HAST, 130C/85%RH 96 Hours - Autoclave 121C 96 Hours - Temperature Cycle, -65/150C 500 Cycles - ESD - HBM 4000 V 1/3/0 ESD - CDM 1000 V 1/3/0 Latch-up (per JESD78) 1/6/0 Electrical Characterization Per Datasheet Parameters 1/30/0 Assembly MQ Per Site Specifications Pass	Test Name / Condition Duration TLV2464CPWR Reference: CD3301RHHR Life Test, 150C 300 Hours - 3/231/0 High Temp Storage Bake 170C 420 Hours - 3/231/0 Biased HAST, 130C/85%RH 96 Hours - 3/231/0 Autoclave 121C 96 Hours - 3/231/0 Temperature Cycle, -65/150C 500 Cycles - 3/231/0 ESD - HBM 4000 V 1/3/0 1/3/0 ESD - CDM 1000 V 1/3/0 1/3/0 Latch-up (per JESD78) 1/6/0 1/6/0 Electrical Characterization Per Datasheet Parameters 1/30/0 1/3/00 Assembly MQ Per Site Specifications Pass Pass	Test Name / Condition Duration TLV2464CPWR Reference: CD3301RHHR QBS Package Reference: TPS2042BD Life Test, 150C 300 Hours - 3/231/0 - High Temp Storage Bake 170C 420 Hours - 3/231/0 - Biased HAST, 130C/85%RH 96 Hours - 3/231/0 - Autoclave 121C 96 Hours - 3/231/0 3/231/0 Temperature Cycle, -65/150C 500 Cycles - 3/231/0 3/231/0 ESD - HBM 4000 V 1/3/0 1/3/0 - ESD - CDM 1000 V 1/3/0 1/3/0 - Latch-up (per JESD78) 1/6/0 1/6/0 - Electrical Characterization Per Site Specifications Pass Pass Pass

- QBS: Qual By Similarity

- Qual Device TLV2464CPWR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status: Qualified Pb-Free (SMT) and Green

Qualified Pb-Free (SMT) and Green

For questions regarding this notice, e-mails can be sent to the contact shown below or your local Field Sales Representative.

Location	E-Mail				
WW Change Management Team	PCN_ww_admin_team@list.ti.com				

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (<u>www.ti.com/legal/termsofsale.html</u>) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.